# **SHOULDER**

规格书编号 SPEC NO:

# 产品规格书 SPECIFICATION

CUSTOMER 客户:	
PRODUCT 产品:	SAW RESONATOR
MODEL NO 型 号:	HDR224M-TO39
PREPARED 编 制:	CHECKED 审 核:
APPROVED 批 准:	DATE日期: 2013-4-22

客户确认 CUSTOMER RECEIVED:					
审核 CHECKED	批准 APPROVED	日期 DATE			

# 无锡市好达电子有限公司 Shoulder Electronics Limited



# 更改历史记录 History Record

更改日期 Date	规格书编号 Spec. No.	产品型号 Part No.	客户产品型号 Customer No.	更改内容描述 Modify Content	备注 Remark



### 1. SCOPE

This specification is applied to a SAW resonator designed for the stabilization of transmitters such as garage door openers and security transmitters.

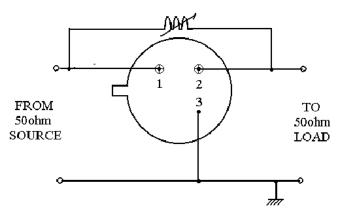
### 2. ELECTRICAL SPECIFICATION

DC Voltage VDC	30V		
AC Voltage Vpp	10V50Hz/60Hz		
Operation temperature	-40°C to +85°C		
Storage temperature	-45°C to +85°C		
RF Power Dissipation	0dBm		

### 2.2Electronic Characteristics

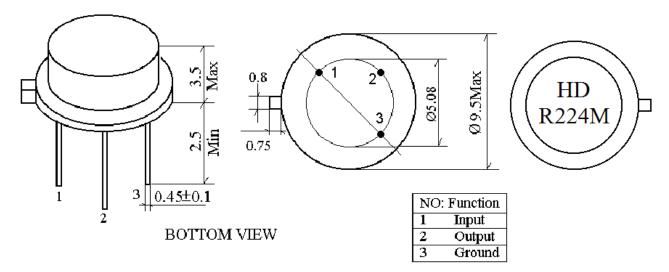
Item		Unites	Minimum	Typical	Maximum
Center Frequency		MHz	223.850	224.000	224.150
Insertion Loss		dB		1.5	2.2
Quality Factor Unload Q			10000	15000	
$50\Omega$ Loaded Q			1000	2000	
Temperature	Turnover Temperature	°C	10	25	40
Stability	Freq.temp.Coefficient	ppm/°C2		0.037	
Frequency Aging		ppm/yr		≤10	
DC. Insulation Resistance		$\mathbf{M}  \Omega$	1.0		
RF Equivalent RLC Model	Motional Resistance R1	Ω		19	26
	Motional Inductance L1	μH		133.811	
	Motional Capacitance C1	fF		2.0507	
Transducer Static Capacitance		pF		2.0	

### **3. TEST CIRCUIT**



# SAW RESONATOR

## 4. DIMENSION



## **5. ENVIRONMENTAL CHARACTERISTICS**

### 5-1 High temperature exposure

Subject the device to  $+85^{\circ}$ C for 16 hours. Then release the resonator into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

5-2 Low temperature exposure

Subject the device to  $-40^{\circ}$ C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

5-3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}$ C for 30 minutes. Following by a high temperature of  $+85^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 2.2.

5-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}$ C  $\pm 10^{\circ}$ C for  $10\pm 1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 2.2.

5-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 2.2.

5-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 2.2.

5-7 Vibration

Subject the device to the vibration for 1 hour each in x, y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 2.2.



### 6. REMARK

#### 6.1 Static voltage

Static voltage between signal load & ground may cause deterioration & destruction of the component. Please avoid static voltage.

### 6.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

### 6.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.